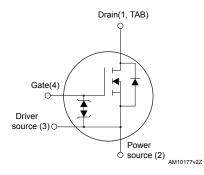


Datasheet

Automotive N-channel 650 V, 33 mΩ typ., 72 A MDmesh DM6 Power MOSFET in a TO247-4 package



TO247-4



Features

Order code	V _{DS}	R _{DS(on)} max.	l _D
STW68N65DM6-4AG	650 V	39 mΩ	72 A

- Designed for automotive applications
- Fast-recovery body diode
- $\bullet \quad \text{Lower $R_{DS(on)}$ per area vs previous generation} \\$
- · Low gate charge, input capacitance and resistance
- 100% avalanche tested
- · Extremely high dv/dt ruggedness
- Excellent switching performance thanks to the extra driving source pin
- · Zener-protected

Applications

· Switching applications



This high-voltage N-channel Power MOSFET is part of the MDmesh DM6 fast-recovery diode series. Compared with the previous MDmesh fast generation, DM6 combines very low recovery charge (Q_{rr}), recovery time (t_{rr}) and excellent improvement in $R_{DS(on)}$ per area with one of the most effective switching behaviors available in the market for the most demanding high-efficiency bridge topologies and ZVS phase-shift converters.



Product status link

STW68N65DM6-4AG

Product summary				
Order code	STW68N65DM6-4AG			
Marking	68N65DM6AG			
Package	TO247-4			
Packing	Tube			



1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	±25	V
I _D	Drain current (continuous) at T _C = 25 °C	72	Α
I _D	Drain current (continuous) at T _C = 100 °C	46	А
I _{DM} ⁽¹⁾	Drain current (pulsed)	280	Α
P _{TOT}	Total power dissipation at T _C = 25 °C	480	W
dv/dt (2)	Peak diode recovery voltage slope	100	V/ns
di/dt (2)	Peak diode recovery current slope	1000	A/µs
dv/dt (3)	MOSFET dv/dt ruggedness	100	V/ns
T _{STG}	Storage temperature range	55 to 150	°C
TJ	Operating junction temperature range	-55 to 150	°C

- 1. Pulse width limited by safe operating area.
- 2. $I_{SD} \le 72 \text{ A}$, V_{DS} (peak) $< V_{(BR)DSS}$, $V_{DD} = 400 \text{ V}$.
- $3. \quad V_{DS} \leq 520 \ V.$

Table 2. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	0.26	°C/W
R _{thj-amb}	Thermal resistance junction-ambient	50	°C/W

Table 3. Avalanche characteristics

ı	Symbol	Parameter	Value	Unit
ſ	I _{AR}	Avalanche current, repetitive or not repetitive (t _p limited by T _J max)	9	Α
	E _{AS}	Single pulse avalanche energy (starting $T_J = 25$ °C, $I_D = I_{AR}$)	1.9	J

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2 Electrical characteristics

 T_C = 25 °C unless otherwise specified

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	650			V
1	Zana mata waltana duain ayunant	V _{GS} = 0 V, V _{DS} = 650 V			10	μА
I _{DSS}	Zero gate voltage drain current	V _{GS} = 0 V, V _{DS} = 650 V, T _C = 125 °C ⁽¹⁾			300	
I _{GSS}	Gate-body leakage current	V _{DS} = 0 V, V _{GS} = ±25 V			±5	μA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	3.25	4	4.75	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10 V, I _D = 36 A		33	39	mΩ

^{1.} Defined by design, not subject to production test.

Table 5. Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance	nce		5900	-	
C _{oss}	Output capacitance	V _{DS} = 100 V, f = 1 MHz, V _{GS} = 0 V	-	260	-	"F
C _{rss}	Reverse transfer capacitance	V_{DS} = 0 to 520 V, V_{GS} = 0 V f = 1 MHz, I_D = 0 A V_{DD} = 520 V, I_D = 72 A, V_{GS} = 0 to 10 V (see Figure 14. Test circuit for gate	-	2.6	-	pF
Coss eq. (1)	Equivalent output capacitance		-	867	-	
R _G	Intrinsic gate resistance		-	1.4	-	Ω
Qg	Total gate charge		-	118	-	
Q _{gs}	Gate-source charge		-	37	-	nC
Q_{gd}	Gate-drain charge	charge behavior)	-	48	-	

^{1.} $C_{\text{oss eq}}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS} .

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	V _{DD} = 325 V, I _D = 36 A,	-	34	-	ns
t _r	Rise time	$R_G = 4.7 \Omega$, $V_{GS} = 10 V$	-	16	-	ns
t _{d(off)}	Turn-off delay time	(see Figure 13. Switching times test circuit for resistive load and	-	92	-	ns
t _f	Fall time	Figure 18. Switching time waveform)	-	10	-	ns

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Table 7. Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		72	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		280	Α
V _{SD} ⁽²⁾	Forward on voltage	V _{GS} = 0 V, I _{SD} = 72 A	-		1.6	V
t _{rr}	Reverse recovery time	I _{SD} = 72 A, di/dt = 100 A/μs, V _{DD} = 60 V	-	142	-	ns
Q _{rr}	Reverse recovery charge	(see Figure 15. Test circuit for inductive	-	0.9	_	μC
I _{RRM}	Reverse recovery current	load switching and diode recovery times)	-	10.6	-	Α
t _{rr}	Reverse recovery time	I _{SD} = 72 A, di/dt = 100 A/μs,	-	310	-	ns
Qrr	Reverse recovery charge	V _{DD} = 60 V, T _J = 150 °C	-	4.5	-	μC
I _{RRM}	Reverse recovery current	(see Figure 15. Test circuit for inductive load switching and diode recovery times)	-	26	-	Α

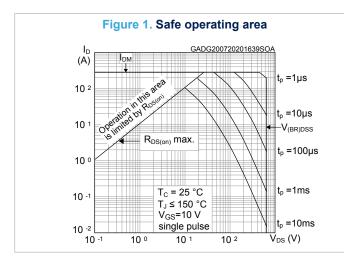
^{1.} Pulse width is limited by safe operating area.

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^{2.} Pulsed: pulse duration = $300 \mu s$, duty cycle 1.5%.



2.1 Electrical characteristics (curves)



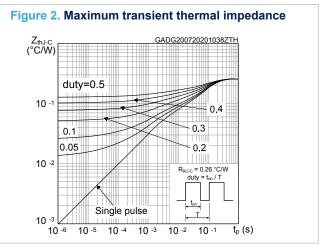
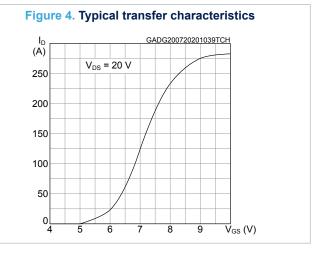
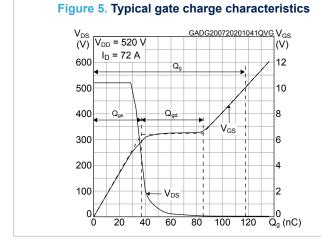
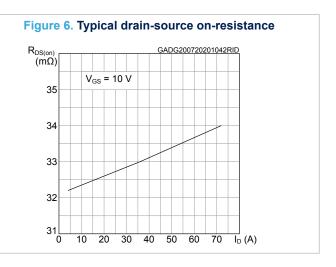


Figure 3. Typical output characteristics Ι_D (A) GADG200720201039OCH V_{GS} = 9, 10 V 250 V_{GS} =8 V 200 150 V_{GS} =7 V100 50 V_{GS} =6 V 20 10 15 V_{DS} (V)







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Figure 7. Typical capacitance characteristics

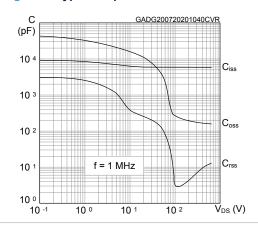


Figure 8. Typical output capacitance stored energy

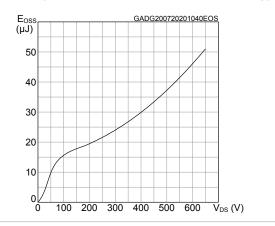


Figure 9. Normalized gate threshold vs temperature

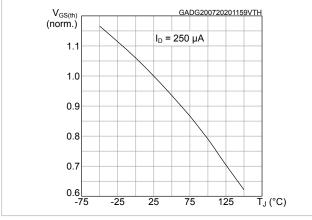


Figure 10. Normalized on-resistance vs temperature

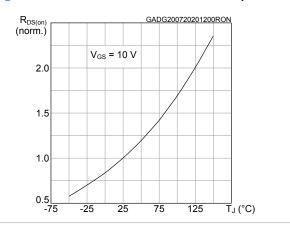


Figure 11. Normalized breakdown voltage vs temperature

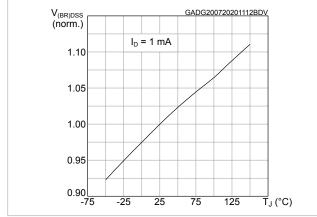
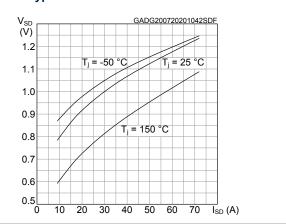


Figure 12. Typical reverse diode forward characteristics



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3 Test circuits

Figure 13. Switching times test circuit for resistive load

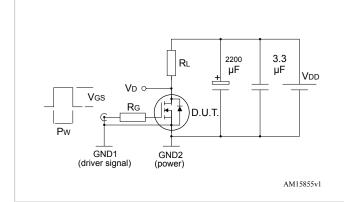


Figure 14. Test circuit for gate charge behavior

V_{GS}

GND1

GND2

GADG180720181011SA

Figure 15. Test circuit for inductive load switching and diode recovery times

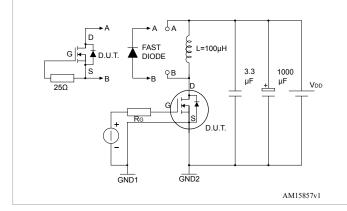


Figure 16. Unclamped inductive load test circuit

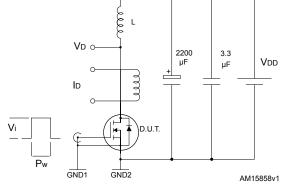


Figure 17. Unclamped inductive waveform

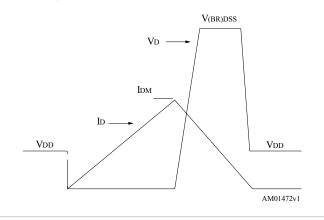
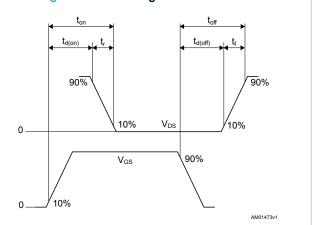


Figure 18. Switching time waveform



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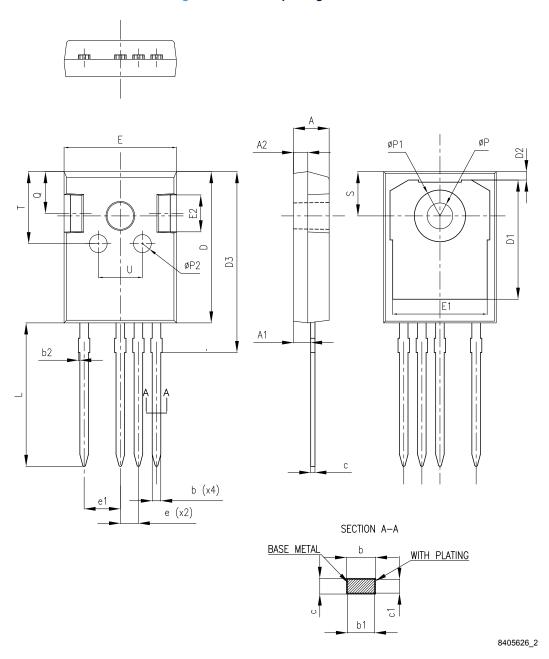


4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

4.1 TO247-4 package information

Figure 19. TO247-4 package outline



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Table 8. TO247-4 mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
А	4.90	5.00	5.10
A1	2.31	2.41	2.51
A2	1.90	2.00	2.10
b	1.16		1.29
b1	1.15	1.20	1.25
b2	0		0.20
С	0.59		0.66
c1	0.58	0.60	0.62
D	20.90	21.00	21.10
D1	16.25	16.55	16.85
D2	1.05	1.20	1.35
D3	24.97	25.12	25.27
E	15.70	15.80	15.90
E1	13.10	13.30	13.50
E2	4.90	5.00	5.10
E3	2.40	2.50	2.60
е	2.44	2.54	2.64
e1	4.98	5.08	5.18
L	19.80	19.92	20.10
Р	3.50	3.60	3.70
P1			7.40
P2	2.40	2.50	2.60
Q	5.60		6.00
S		6.15	
Т	9.80		10.20
U	6.00		6.40

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Revision history

Table 9. Document revision history

Date	Version	Changes
21-Apr-2020	1	First release.
20-Jul-2020	2	Modified Table 1. Absolute maximum ratings, Table 3. Avalanche characteristics, Table 4. On/off states, Table 5. Dynamic characteristics, Table 6. Switching times and Table 7. Source-drain diode.
		Added Section 2.1 Electrical characteristics (curves). Minor text changes.

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